

**Notice of References Cited**

Application/Control No.

09/805,395

Applicant(s)/Patent Under  
Reexamination  
HANSEN ET AL.

Examiner

Ming Chow

Art Unit

2645

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,452,289	09-1995	Sharma et al.	370/286
	B	US-5,274,738	12-1993	Daly et al.	704/200
	C	US-5,091,932	02-1992	Tsuda, Yukio	379/100.15
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	K	US-			
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